## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | PARK ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,631,122	10-2003	Arunachalam et al.	370/332
	В	US-6,222,829	04-2001	Karlsson et al.	370/329
	С	US-6,801,508	10-2004	Lim, Byung Keun	370/310.1
	D	US-6,885,658	04-2005	Ress et al.	370/352
	Е	US-6,788,953	09-2004	Cheah et al.	455/550.1
	F	US-6,799,038	09-2004	Gopikanth, Venkat	455/435.2
	G	US-6,069,883	05-2000	Ejzak et al.	370/335
	н	US-6,829,486	12-2004	McKenna et al.	455/464
	ı	US-6,731,642	05-2004	Borella et al.	370/401
	J	US-6,546,251	04-2003	Dalsgaard et al.	455/437
	К	US-6,324,279	11-2001	Kalmanek et al.	379/229
	٦	US-6,469,993	10-2002	Seo et al.	370/329
	М	US-6,801,508	10-2004	Lim, Byung Keun	370/310.1

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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